

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/023,746	<b>Applicant(s)/Patent under Reexamination</b> LEE, JAE KYUNG
	<b>Examiner</b> James H. Zurita	<b>Art Unit</b> 3625

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner